

FEATURES

- Ultra-fine Trench Gate IGBT
- Cu Base with Enhanced Si₃N₄ Substrates
- High Thermal Cycling Capability

APPLICATIONS

- Wind Turbines
- Power Charging Equipment
- Smart Grid
- High Reliability Inverters

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM800M1HS17-PG500 is a half bridge 1700V, trench gate, insulated gate bipolar transistor (IGBT) module with enhanced field stop. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 8μs short circuit withstand.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

ORDERING INFORMATION

Order As:

DIM800M1HS17-PG500

Note: When ordering, please use the complete part number

KEY PARAMETERS

V_{CES}	1700V
$V_{CE(sat)}$ * (typ)	1.65V
I_C (max)	800A
$I_{C(PK)}$ (max)	1600A

* Measured at the auxiliary terminals

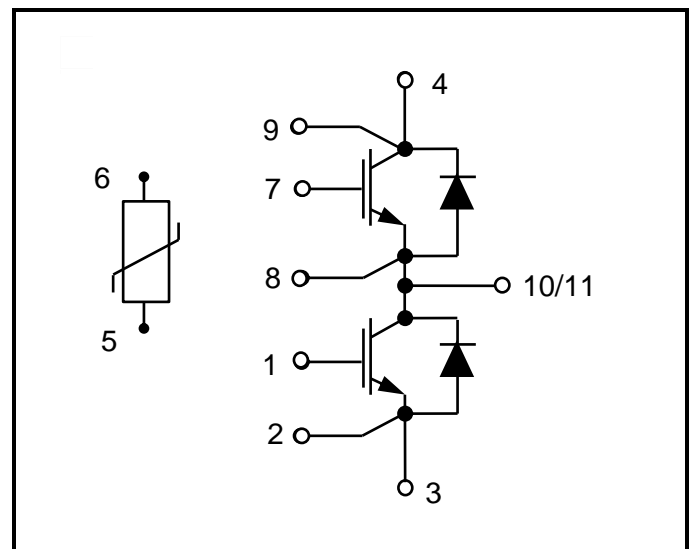


Fig. 1 Circuit configuration



Fig. 2 Package

ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under ‘Absolute Maximum Ratings’ may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V _{CES}	Collector-emitter voltage	V _{GE} = 0V, T _C = 25°C	1700	V
V _{GES}	Gate-emitter voltage	T _C = 25°C	±20	V
I _C	Continuous collector current	T _C = 80°C, T _{vj} = 175°C	800	A
I _{C(PK)}	Peak collector current	t _p = 1ms	1600	A
P _{max}	Max. transistor power dissipation	T _C = 25°C, T _{vj} = 175°C	4	kW
I ² t	Diode I ² t value	V _R = 0, t _p = 10ms, T _{vj} = 175°C	37	kA ² s
V _{isol}	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	3400	V

THERMAL AND MECHANICAL RATINGS

Internal insulation material:	Si ₃ N ₄
Baseplate material:	Cu
Creepage distance – Terminal to heatsink:	14.5mm
Creepage distance – Terminal to terminal:	13.0mm
Clearance – Terminal to heatsink:	12.5mm
Clearance – Terminal to terminal:	10mm
CTI (Comparative Tracking Index):	>200

Symbol	Parameter	Test Conditions	Min	Typ.	Max	Units
R _{th(j-c)}	Thermal resistance – IGBT	Continuous dissipation – junction to case	-	-	37	°C/kW
R _{th(j-c)}	Thermal resistance – diode		-	-	63	°C/kW
R _{th(c-h)}	Thermal resistance – case to heatsink (IGBT)	Mounting torque 5Nm (with mounting grease 1W/m°C)	-	28	-	°C/kW
R _{th(c-h)}	Thermal resistance – case to heatsink (Diode)		-	38	-	°C/kW
T _j	Junction temperature – under switching conditions	IGBT	-40	-	175	°C
		Diode	-40	-	175	°C
T _{stg}	Storage temperature range	-	-40	-	125	°C
	Screw torque	Mounting – M5	3	-	6	Nm
		Electrical connections – M6	3	-	6	Nm

ELECTRICAL CHARACTERISTICS

$T_{case} = 25^{\circ}\text{C}$ unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
I_{CES}	Collector cut-off current	$V_{GE} = 0\text{V}, V_{CE} = V_{CES}$			1	mA
		$V_{GE} = 0\text{V}, V_{CE} = V_{CES}, T_C = 150^{\circ}\text{C}$			20	mA
		$V_{GE} = 0\text{V}, V_{CE} = V_{CES}, T_C = 175^{\circ}\text{C}$			30	mA
I_{GES}	Gate leakage current	$V_{GE} = \pm 20\text{V}, V_{CE} = 0\text{V}$			0.5	μA
$V_{GE(TH)}$	Gate threshold voltage	$I_C = 15\text{mA}, V_{GE} = V_{CE}$	5.40	6.00	6.60	V
$V_{CE(sat)}$	Collector-emitter saturation voltage	$V_{GE} = 15\text{V}, I_C = 800\text{A}$		1.65	2.05	V
		$V_{GE} = 15\text{V}, I_C = 800\text{A}, T_j = 150^{\circ}\text{C}$		2.05		V
		$V_{GE} = 15\text{V}, I_C = 800\text{A}, T_j = 175^{\circ}\text{C}$		2.10		V
I_F	Diode forward current	DC		800		A
I_{FM}	Diode maximum forward current	$t_p = 1\text{ms}$		1600		A
V_F	Diode forward voltage	$I_F = 800\text{A}$		1.85	2.25	V
		$I_F = 800\text{A}, T_j = 150^{\circ}\text{C}$		2.05		V
		$I_F = 800\text{A}, T_j = 175^{\circ}\text{C}$		2.05		V
C_{ies}	Input capacitance	$V_{CE} = 25\text{V}, V_{GE} = 0\text{V}, f = 100\text{kHz}$		185		nF
Q_g	Gate charge	$\pm 15\text{V}$		8.6		μC
C_{res}	Reverse transfer capacitance	$V_{CE} = 25\text{V}, V_{GE} = 0\text{V}, f = 100\text{kHz}$		0.4		nF
L_M	Module inductance			28		nH
R_{CC+EE}	Module lead resistance, Terminal - chip			1		$\text{m}\Omega$
R_{Gint}	Internal gate resistor			0.6		Ω
SC_{Data}	Short circuit current, I_{sc}	$T_j = 175^{\circ}\text{C}, V_{CC} = 1000\text{V}$ $t_p \leq 8\mu\text{s}, V_{GE} \leq 15\text{V}$ $V_{CE(max)} = V_{CES} - L^* \times di/dt$ IEC 60747-9		3000		A

Note:

* L is the circuit inductance + L_M

NTC-Thermistor Data

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
R_{25}	Rated resistance	$T_C = 25^{\circ}\text{C}$		5		$\text{k}\Omega$
$\Delta R/R$	Deviation of R_{100}	$T_C = 100^{\circ}\text{C}, R_{100} = 493\Omega$	-5		5	%
P_{25}	Power dissipation	$T_C = 25^{\circ}\text{C}$			20	mW
$B_{25/50}$	B-value	$R_2 = R_{25} \exp [B_{25/50}(1/T_2 - 1/(298.15\text{K}))]$		3375		K
$B_{25/80}$		$R_2 = R_{25} \exp [B_{25/80}(1/T_2 - 1/(298.15\text{K}))]$		3411		K
$B_{25/100}$		$R_2 = R_{25} \exp [B_{25/100}(1/T_2 - 1/(298.15\text{K}))]$		3433		K

ELECTRICAL CHARACTERISTICS

 $T_{case} = 25^{\circ}C$ unless stated otherwise

Symbol	Parameter	Test Conditions		Min	Typ.	Max	Units
$t_{d(off)}$	Turn-off delay time	$I_C = 800A$ $V_{CE} = 900V$ $V_{GE} = \pm 15V$ $R_{G(OFF)} = 6.8\Omega$ $R_{G(ON)} = 0.5\Omega$ $L_S = 35nH$	$dv/dt = 3500V/\mu s$		1320		ns
t_f	Fall time				195		ns
E_{OFF}	Turn-off energy loss				217		mJ
$t_{d(on)}$	Turn-on delay time		$di/dt = 6400A/\mu s$		270		ns
t_r	Rise time				85		ns
E_{ON}	Turn-on energy loss				98		mJ
Q_{rr}	Diode reverse recovery charge	$I_F = 800A$ $V_{CE} = 900V$ $di/dt = 6400A/\mu s$		150		μC	
I_{rr}	Diode reverse recovery current			670		A	
E_{rec}	Diode reverse recovery energy			109		mJ	

 $T_{case} = 150^{\circ}C$ unless stated otherwise

Symbol	Parameter	Test Conditions		Min	Typ.	Max	Units
$t_{d(off)}$	Turn-off delay time	$I_C = 800A$ $V_{CE} = 900V$ $V_{GE} = \pm 15V$ $R_{G(OFF)} = 6.8\Omega$ $R_{G(ON)} = 0.5\Omega$ $L_S = 35nH$	$dv/dt = 3500V/\mu s$		1520		ns
t_f	Fall time				385		ns
E_{OFF}	Turn-off energy loss				288		mJ
$t_{d(on)}$	Turn-on delay time		$di/dt = 6400A/\mu s$		294		ns
t_r	Rise time				100		ns
E_{ON}	Turn-on energy loss				214		mJ
Q_{rr}	Diode reverse recovery charge	$I_F = 800A$ $V_{CE} = 900V$ $di/dt = 6400A/\mu s$		270		μC	
I_{rr}	Diode reverse recovery current			588		A	
E_{rec}	Diode reverse recovery energy			174		mJ	

 $T_{case} = 175^{\circ}C$ unless stated otherwise

Symbol	Parameter	Test Conditions		Min	Typ.	Max	Units
$t_{d(off)}$	Turn-off delay time	$I_C = 800A$ $V_{CE} = 900V$ $V_{GE} = \pm 15V$ $R_{G(OFF)} = 6.8\Omega$ $R_{G(ON)} = 0.5\Omega$ $L_S = 35nH$	$dv/dt = 3500V/\mu s$		1565		ns
t_f	Fall time				410		ns
E_{OFF}	Turn-off energy loss				298		mJ
$t_{d(on)}$	Turn-on delay time		$di/dt = 6400A/\mu s$		300		ns
t_r	Rise time				110		ns
E_{ON}	Turn-on energy loss				246		mJ
Q_{rr}	Diode reverse recovery charge	$I_F = 800A$ $V_{CE} = 900V$ $di/dt = 6400A/\mu s$		305		μC	
I_{rr}	Diode reverse recovery current			560		A	
E_{rec}	Diode reverse recovery energy			194		mJ	

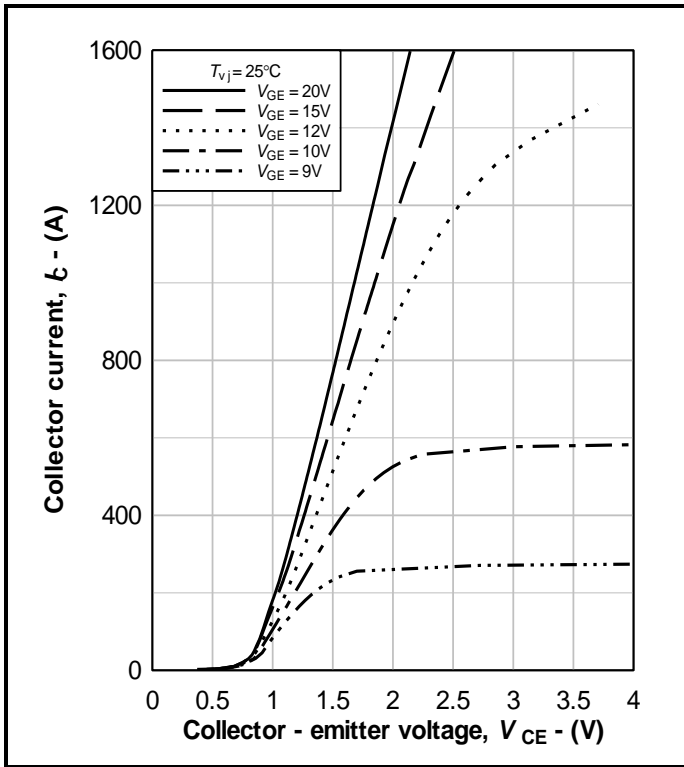


Fig. 3 Typical IGBT output characteristics, $I_c = f(V_{CE})$

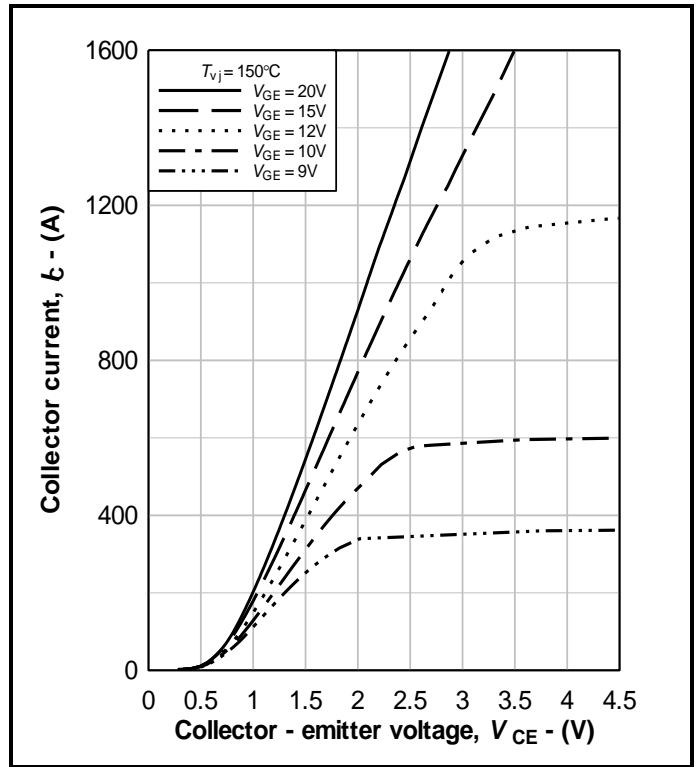


Fig. 4 Typical IGBT output characteristics, $I_c = f(V_{CE})$

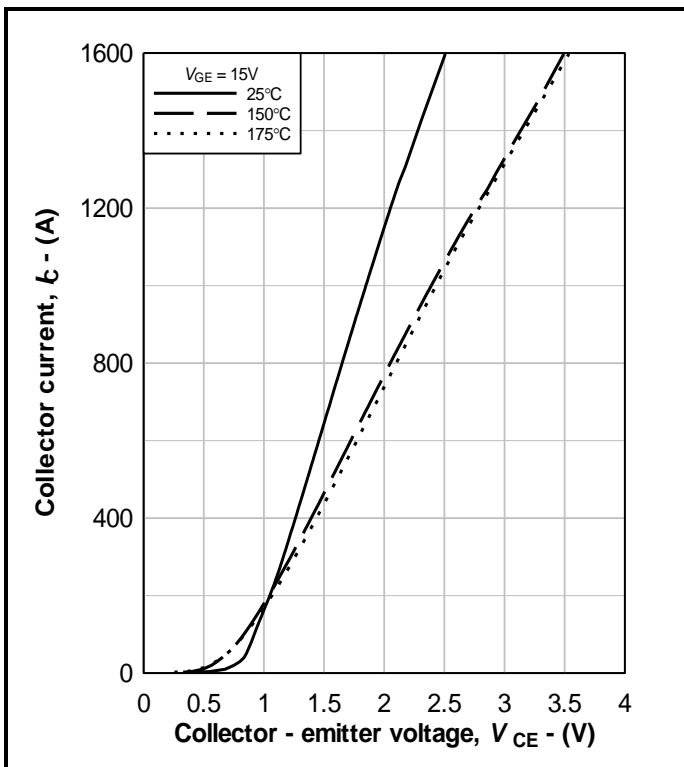


Fig. 5 Typical IGBT output characteristics, $I_c = f(V_{CE})$

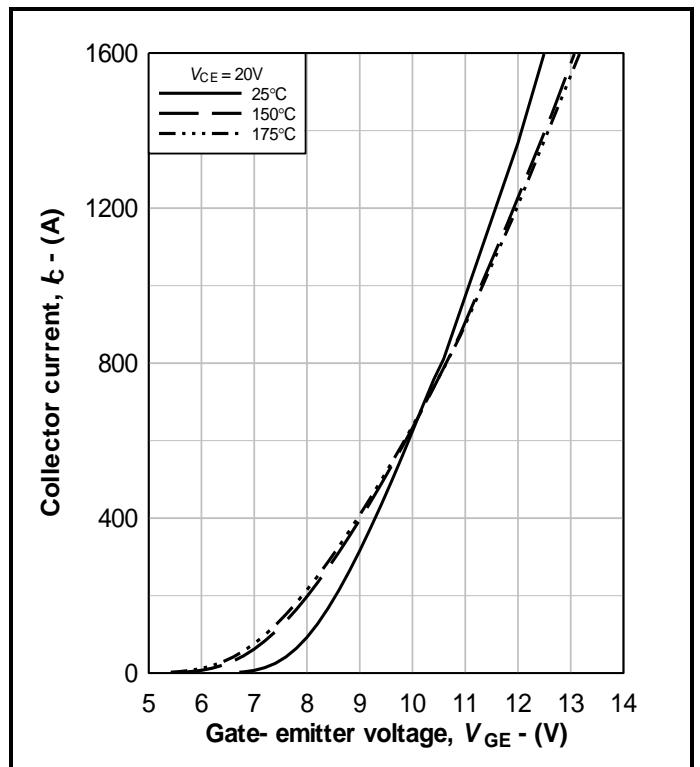


Fig. 6 Typical IGBT transfer characteristics, $I_c = f(V_{GE})$

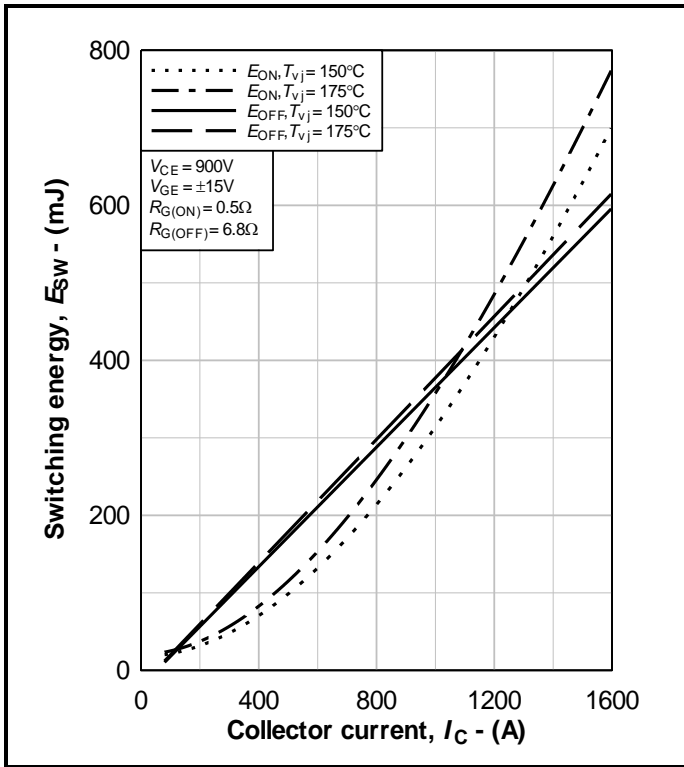


Fig. 7 Typical IGBT switching energy, $E_{ON} = f(I_C)$, $E_{OFF} = f(I_C)$

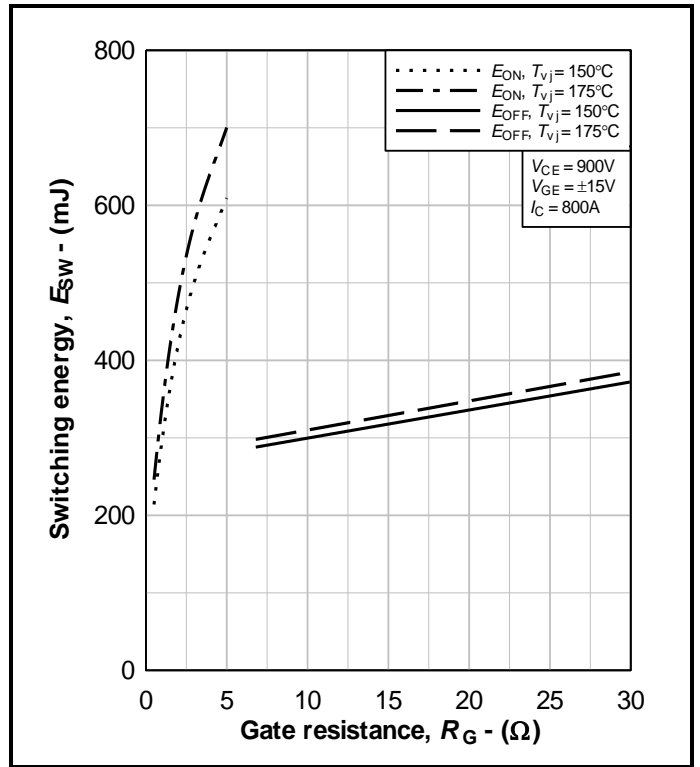


Fig. 8 Typical IGBT switching energy, $E_{ON} = f(R_G)$, $E_{OFF} = f(R_G)$

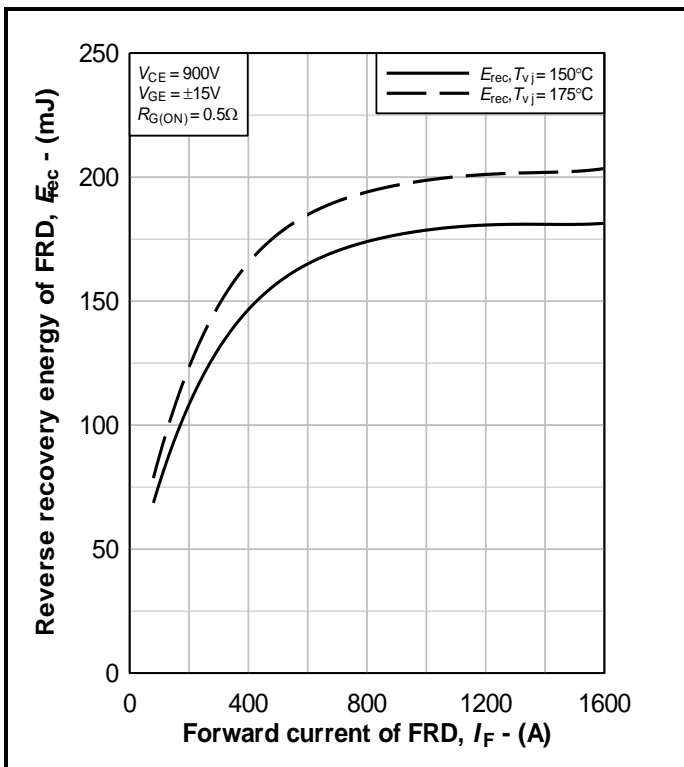


Fig. 9 Typical FRD E_{rec} , $E_{rec} = f(I_F)$

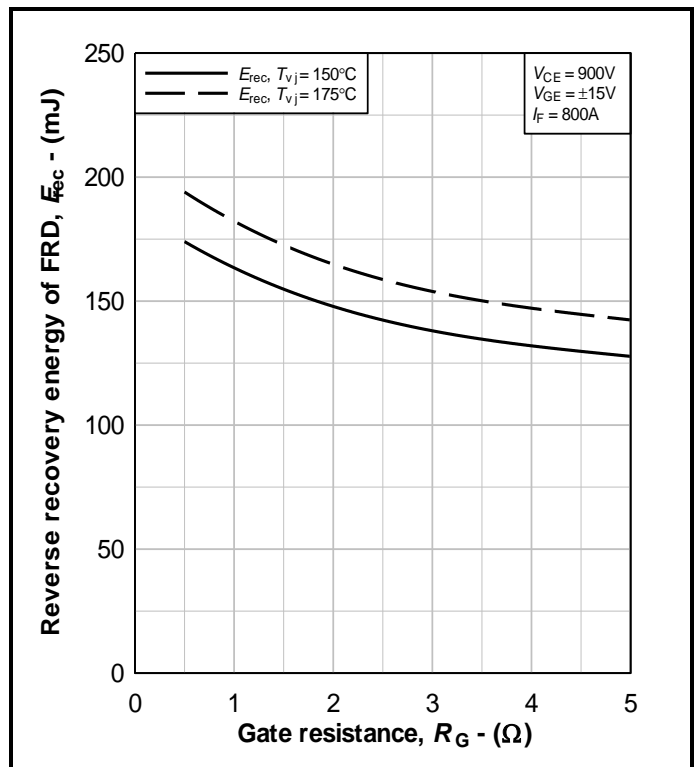


Fig. 10 Typical FRD E_{rec} , $E_{rec} = f(R_G)$

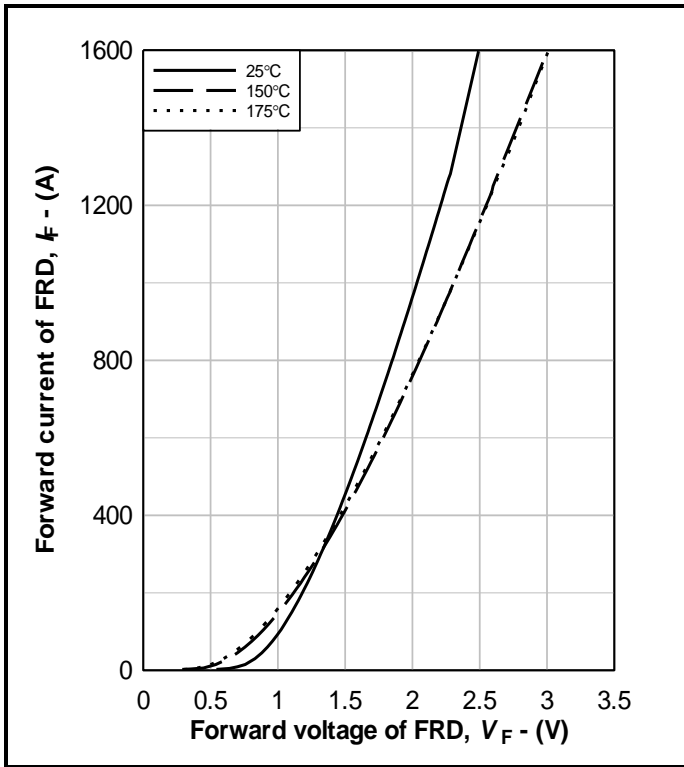


Fig. 11 Diode typical forward characteristics, $I_F = f(V_F)$

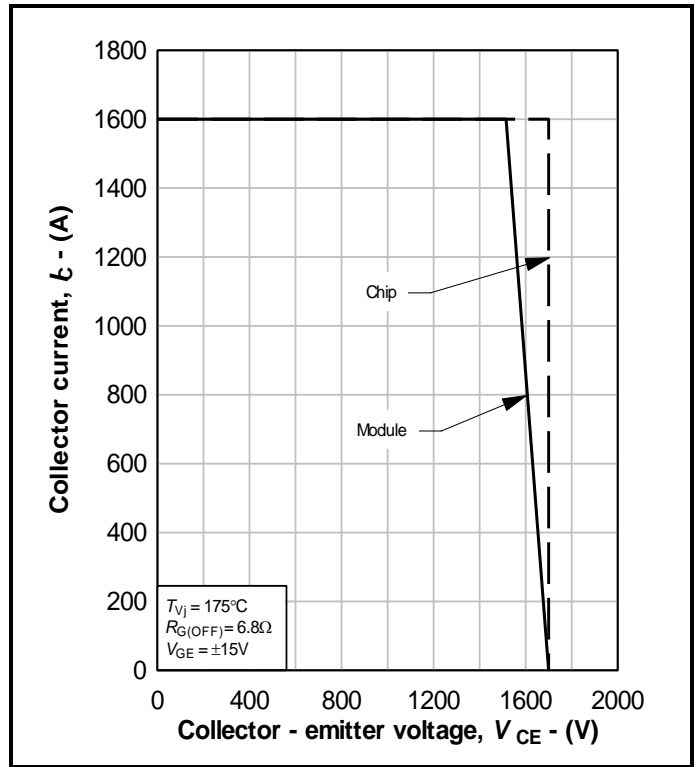


Fig. 12 Reverse bias safe operating area of IGBT, $I_c = f(V_{CE})$

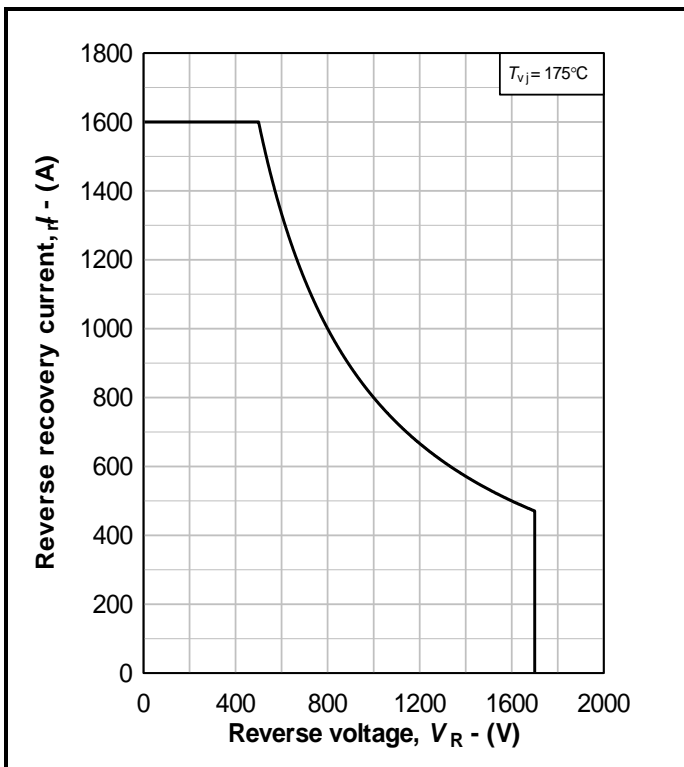


Fig. 13 Reverse bias safe operating area of FRD, $I_{rr} = f(V_R)$

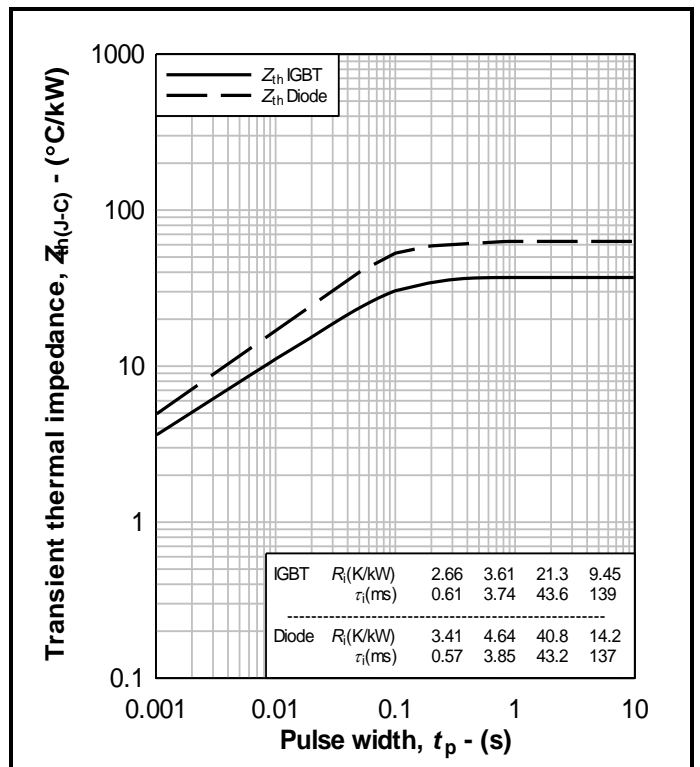


Fig. 14 Transient thermal impedance, $Z_{th(J-C)} = f(t_p)$

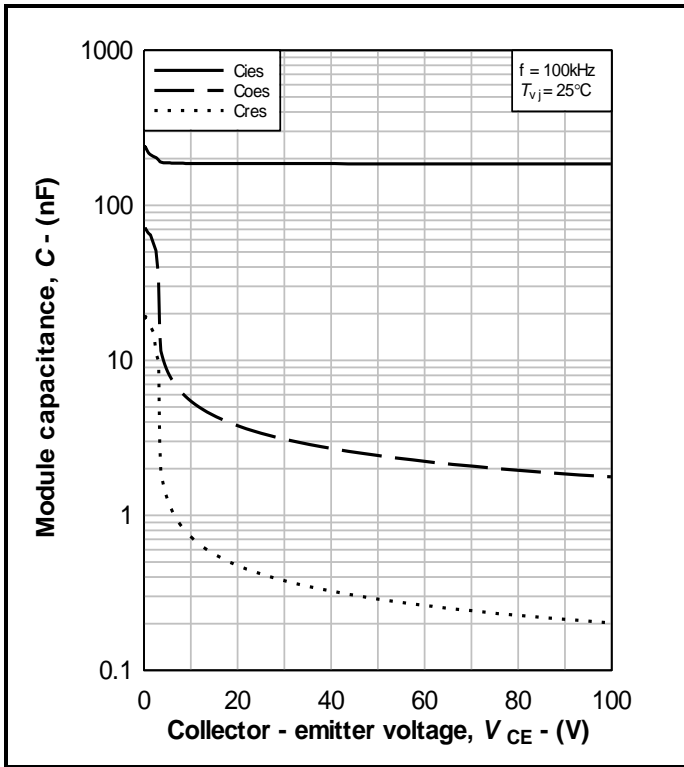


Fig. 15 Typical capacitor characteristic, $C = f(V_{CE})$

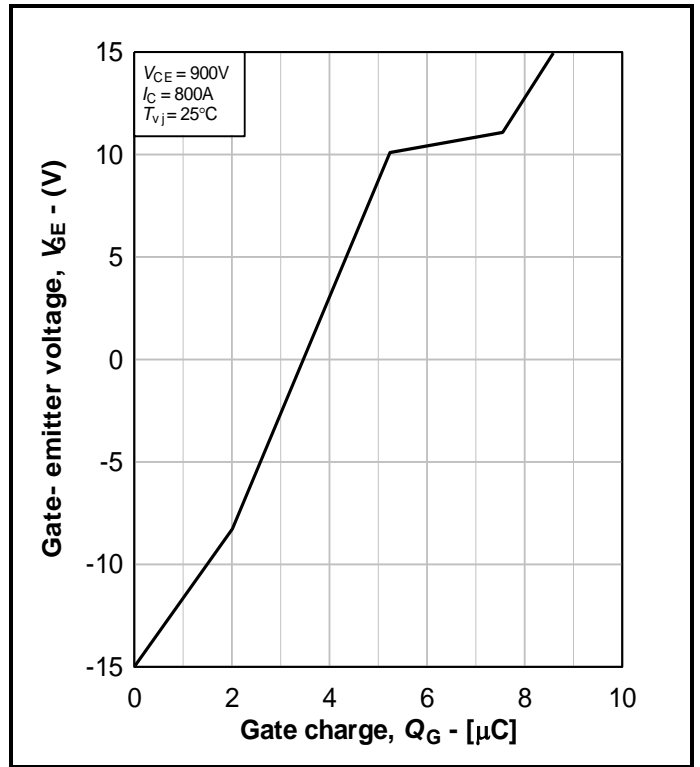


Fig. 16 Typical gate charge characteristic, $V_{GE} = f(Q_G)$

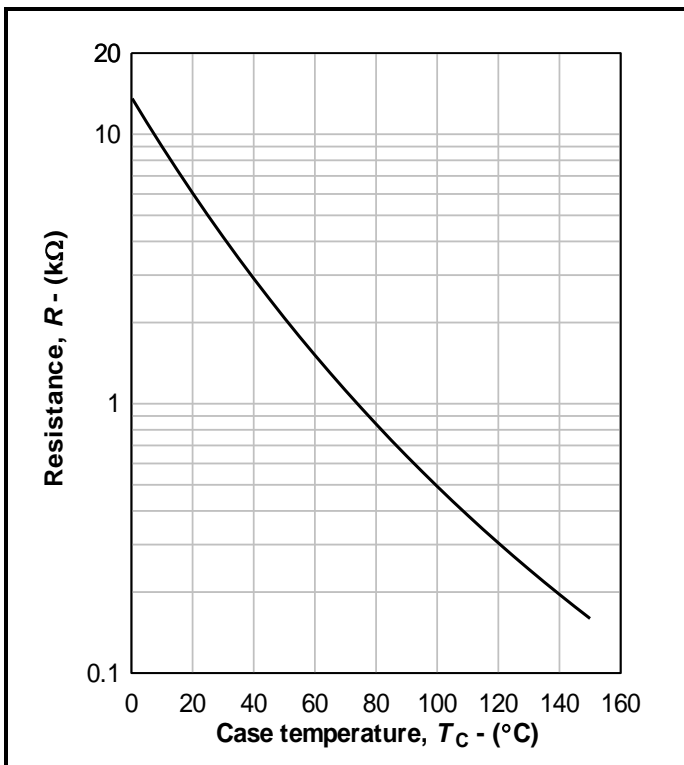


Fig. 17 Typical NTC thermistor characteristic, $R = f(T_C)$

PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services.
All dimensions in mm, unless stated otherwise.
DO NOT SCALE.

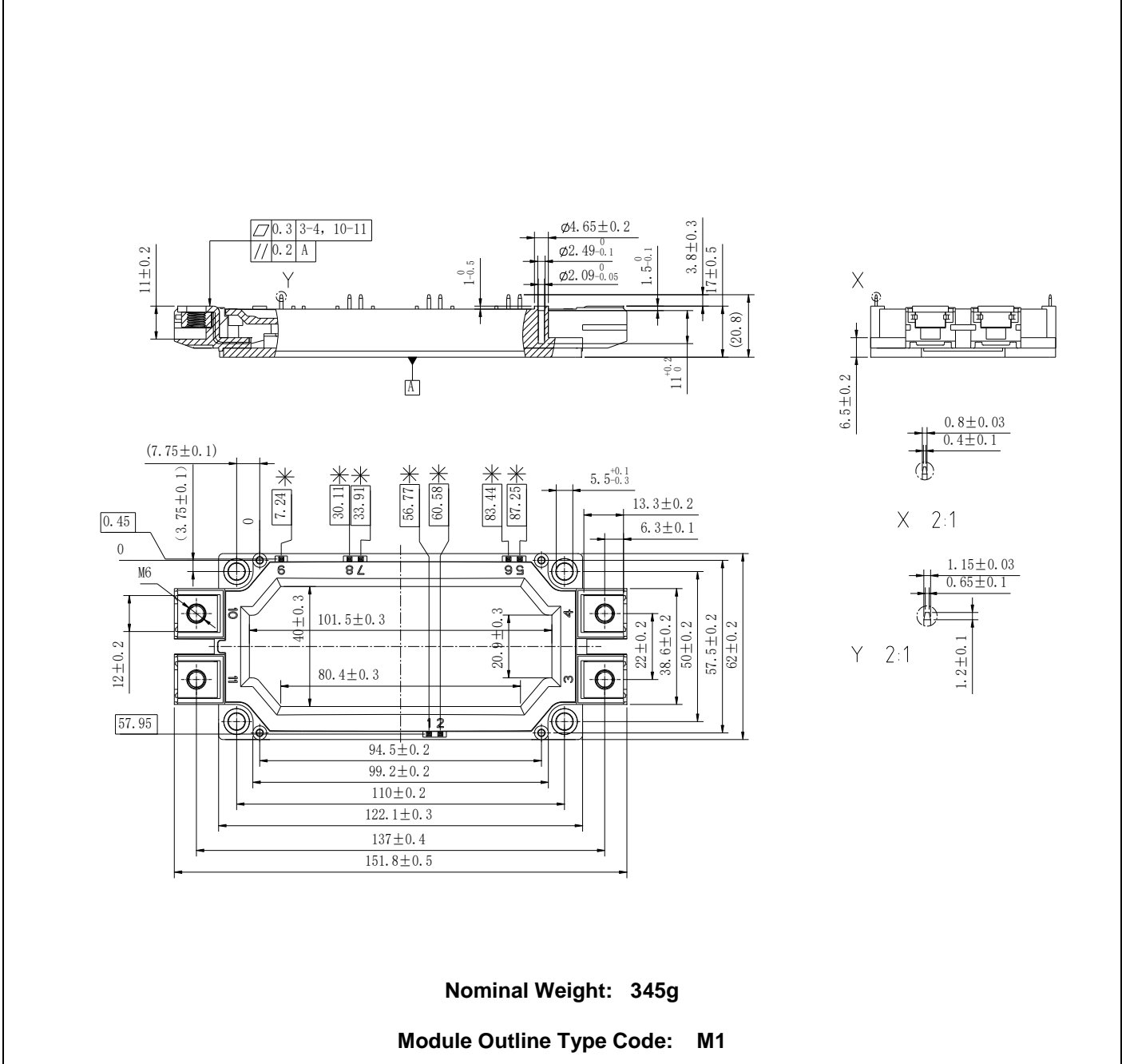


Fig. 18 Module outline drawing

IMPORTANT INFORMATION:

This publication is provided for information only and not for resale.

The products and information in this publication are intended for use by appropriately trained technical personnel.

Due to the diversity of product applications, the information contained herein is provided as a general guide only and does not constitute any guarantee of suitability for use in a specific application. The user must evaluate the suitability of the product and the completeness of the product data for the application. The user is responsible for product selection and ensuring all safety and any warning requirements are met. Should additional product information be needed please contact Customer Service.

Although we have endeavoured to carefully compile the information in this publication it may contain inaccuracies or typographical errors. The information is provided without any warranty or guarantee of any kind.

This publication is an uncontrolled document and is subject to change without notice. When referring to it please ensure that it is the most up to date version and has not been superseded.

The products are not intended for use in applications where a failure or malfunction may cause loss of life, injury or damage to property. The user must ensure that appropriate safety precautions are taken to prevent or mitigate the consequences of a product failure or malfunction.

The products must not be touched when operating because there is a danger of electrocution or severe burning. Always use protective safety equipment such as appropriate shields for the product and wear safety glasses. Even when disconnected any electric charge remaining in the product must be discharged and allowed to cool before safe handling using protective gloves.

Extended exposure to conditions outside the product ratings may affect reliability leading to premature product failure. Use outside the product ratings is likely to cause permanent damage to the product. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture, a large current to flow or high voltage arcing, resulting in fire or explosion. Appropriate application design and safety precautions should always be followed to protect persons and property.

Product Status & Product Ordering:

We annotate datasheets in the top right hand corner of the front page, to indicate product status if it is not yet fully approved for production. The annotations are as follows:-

Target Information:	This is the most tentative form of information and represents a very preliminary specification. No actual design work on the product has been started.
Preliminary Information:	The product design is complete and final characterisation for volume production is in progress. The datasheet represents the product as it is now understood but details may change.
No Annotation:	The product has been approved for production and unless otherwise notified by Dynex any product ordered will be supplied to the current version of the data sheet prevailing at the time of our order acknowledgement.

All products and materials are sold and services provided subject to Dynex's conditions of sale, which are available on request.

Any brand names and product names used in this publication are trademarks, registered trademarks or trade names of their respective owners.

HEADQUARTERS OPERATIONS**DYNEX SEMICONDUCTOR LTD**

Doddington Road, Lincoln, Lincolnshire, LN6 3LF,
United Kingdom

Tel: +44(0)1522 500500

Web: <http://www.dynexsemi.com>

CUSTOMER SERVICE**DYNEX SEMICONDUCTOR LTD**

Doddington Road, Lincoln, Lincolnshire, LN6 3LF,
United Kingdom

Tel: +44(0)1522 502753 / 502901

Email: powersolutions@dynexsemi.com